


<b>Search Notes</b>  	<b>Application/Control No.</b>  10556457	<b>Applicant(s)/Patent Under Reexamination</b>  SEIFERT ET AL.
	<b>Examiner</b>  DEREK S CHAPEL	<b>Art Unit</b>  2872

SEARCHED			
Class	Subclass	Date	Examiner
359	359-362, 368, 379-384, 391 (text only, see attached)	12/9/2008	DSC
356	244, 246 (text only, see attached)	12/9/2008	DSC
600	101, 136-137, 139-150, 164, 172-173 (text only, see attached)	12/9/2008	DSC

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Arnel Lavarias about the search	12/9/2008	DSC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/D. S. C./ Examiner.Art Unit 2872	
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